Se	arch Notes	

Application/Contr	ol No.	Applicant(s Reexamina	)/Patent under tion
10/609,414		TAKAYAN	AGI ET AL.
Examiner		Art Unit	
Eric Culbreth		3616	

SEARCHED			
Class	Subclass	Date	Examiner
180	210,214 213,215 216	2/25/2006	EC
280	124.125		
280	124.134		
280	124.135		
280	124.136		
280	124.157		
280	124.162		
280	124.177		
280	124.178		

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
,			
	.		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
	;	